

Vishay Siliconix

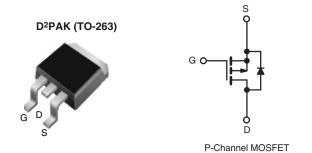
RoHS'

COMPLIANT

HALOGEN FREE

## **Power MOSFET**

| PRODUCT SUMMARY            |                          |                              |  |  |  |  |
|----------------------------|--------------------------|------------------------------|--|--|--|--|
| V <sub>DS</sub> (V)        | - 10                     | - 100                        |  |  |  |  |
| $R_{DS(on)}(\Omega)$       | V <sub>GS</sub> = - 10 V | V <sub>GS</sub> = - 10 V 1.2 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC) | 8.7                      |                              |  |  |  |  |
| Q <sub>gs</sub> (nC)       | 2.2                      |                              |  |  |  |  |
| Q <sub>gd</sub> (nC)       | 4.1                      |                              |  |  |  |  |
| Configuration              | Single                   |                              |  |  |  |  |



#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- · Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D<sup>2</sup>PAK (TO-263) is a surface mount power package capable of accommodating die size up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

| ORDERING INFORMATION            |                             |                               |  |  |  |
|---------------------------------|-----------------------------|-------------------------------|--|--|--|
| Package                         | D <sup>2</sup> PAK (TO-263) | D <sup>2</sup> PAK (TO-263)   |  |  |  |
| Lead (Pb)-free and Halogen-free | SiHF9510S-GE3               | SiHF9510STRL-GE3 <sup>a</sup> |  |  |  |
| Lead (Pb)-free                  | IRF9510SPbF                 | IRF9510STRLPbFa               |  |  |  |
|                                 | SiHF9510S-E3                | SiHF9510STL-E3a               |  |  |  |

### Note

See device orientation.

| PARAMETER                                     | SYMBOL  | LIMIT            | UNIT  |     |  |
|---|---|------------------|-------|-----|--|
| Drain-Source Voltage                          |   | $V_{DS}$         | - 100 | V   |  |
| Gate-Source Voltage                           |   | $V_{GS}$         | ± 20  | 1 V |  |
| Continuous Drain Current                      | la  | - 4.0            | А     |     |  |
| Continuous Drain Current                      | ID  | - 2.8            |       |     |  |
| Pulsed Drain Current <sup>a</sup>             | I <sub>DM</sub>                                 | - 16             | 1     |     |  |
| Linear Derating Factor                        |   | 0.29             | W/°C  |     |  |
| Linear Derating Factor (PCB Mount)e           |   | 0.025            |       |     |  |
| Single Pulse Avalanche Energy <sup>b</sup>    | E <sub>AS</sub>                                 | 200              | mJ    |     |  |
| Avalanche Current <sup>a</sup>                | I <sub>AR</sub>                                 | - 4.0            | А     |     |  |
| Repetiitive Avalanche Energy <sup>a</sup>     | E <sub>AR</sub>                                 | 4.3              | mJ    |     |  |
| Maximum Power Dissipation                     | P <sub>D</sub>                                  | 43               | W     |     |  |
| Maximum Power Dissipation (PCB Mount)e        |   | 3.7              |       |     |  |
| Peak Diode Recovery dV/dtc                    | dV/dt   | - 5.5            | V/ns  |     |  |
| Operating Junction and Storage Temperature Ra | T <sub>J</sub> , T <sub>stg</sub> - 55 to + 175 |                  | °C    |     |  |
| Soldering Recommendations (Peak Temperature)  |   | 300 <sup>d</sup> | 7     |     |  |

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = -25$  V, starting  $T_J = 25$  °C, L = 18 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = -4.0$  A (see fig. 12).
- c.  $I_{SD} \le -4.0 \text{ A}$ ,  $dI/dt \le 75 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_{J} \le 175 \text{ °C}$ .
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRF9510S, SiHF9510S

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| THERMAL RESISTANCE RATINGS                           |                   |      |      |      |  |
|--|-------------------|------|------|------|--|
| PARAMETER  | SYMBOL            | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient                          | R <sub>thJA</sub> | -    | 62   |      |  |
| Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup> | R <sub>thJA</sub> | -    | 40   | °C/W |  |
| Maximum Junction-to-Case (Drain)                     | $R_{thJC}$        | -    | 3.5  |      |  |

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| PARAMETER                                     | SYMBOL                | TEST CONDITIONS   |   | MIN.  | TYP.                 | MAX.             | UNIT    |
|---|-----------------------|---|---|-------|----------------------|------------------|---------|
| Static  |                       |   |   |       |                      |                  |         |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>       | $V_{GS} = 0$ , $I_D = -250 \mu A$   |   | - 100 | -                    | -                | V       |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$ | Reference   | e to 25 °C, I <sub>D</sub> = - 1 mA   | =-    | - 0.091              | -                | V/°C    |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | V <sub>GS</sub> , I <sub>D</sub> = - 250 μA   | - 2.0 | -                    | - 4.0            | V       |
| Gate-Source Leakage                           | I <sub>GSS</sub>      |   | V <sub>GS</sub> = ± 20 V  | -     | -                    | ± 100            | nA      |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>      |   | - 100 V, V <sub>GS</sub> = 0 V<br>V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C |       | -                    | - 100<br>- 500   | μA      |
| Drain-Source On-State Resistance              | R <sub>DS(on)</sub>   | V <sub>GS</sub> = - 10 V  | I <sub>D</sub> = - 2.4 A <sup>b</sup>   | _     | -                    | 1.2              | Ω       |
| Forward Transconductance                      | 9 <sub>fs</sub>       | V <sub>DS</sub> =   | - 50 V, I <sub>D</sub> = - 2.4 A <sup>b</sup>                                       | 1.0   | -                    | -                | S       |
| Dynamic                                       |                       |   |   |       |                      |                  | ı       |
| Input Capacitance                             | C <sub>iss</sub>      |   | $V_{GS} = 0 V$ ,  | -     | 200                  | -                | pF      |
| Output Capacitance                            | C <sub>oss</sub>      |   | $V_{DS} = -25 V$ ,  | -     | 94                   | -                |         |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>      | f = 1   | f = 1.0 MHz, see fig. 5   |       | 18                   | -                |         |
| Total Gate Charge                             | Qg                    |   |   |       | -                    | 8.7              |         |
| Gate-Source Charge                            | Q <sub>gs</sub>       | V <sub>GS</sub> = - 10 V  | $I_D = -4.0 \text{ A}, V_{DS} = -80 \text{ V},$<br>see fig. 6 and 13 <sup>b</sup>   | -     | -                    | 2.2              | nC      |
| Gate-Drain Charge                             | Q <sub>gd</sub>       | ]   | oos ng. o and ro  | -     | -                    | 4.1              |         |
| Turn-On Delay Time                            | t <sub>d(on)</sub>    |   |   | -     | 10                   | -                |         |
| Rise Time                                     | t <sub>r</sub>        | V <sub>DD</sub> =   | - 50 V, I <sub>D</sub> = - 4.0 A,   | -     | 27                   | -                | ]       |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>   | $R_g = 24 \Omega$ , $R_D = 11 \Omega$ , see fig. $10^b$                                   |   | -     | 15                   | -                | ns<br>_ |
| Fall Time                                     | t <sub>f</sub>        |   |   | -     | 17                   | -                |         |
| Internal Drain Inductance                     | L <sub>D</sub>        | Between lead,<br>6 mm (0.25") from  |   | -     | 4.5                  | -                | nH      |
| Internal Source Inductance                    | L <sub>S</sub>        | package and center of die contact   |   | -     | 7.5                  | -                | 1111    |
| <b>Drain-Source Body Diode Characteristic</b> | s                     |   |   |       |                      |                  |         |
| Continuous Source-Drain Diode Current         | Is                    | MOSFET symbol showing the   |   | ı     | -                    | - 4.0            | А       |
| Pulsed Diode Forward Current <sup>a</sup>     | I <sub>SM</sub>       | integral reverse p - n junction diode   |   | ı     | -                    | - 16             | ^       |
| Body Diode Voltage                            | $V_{SD}$              | $T_{J} = 25  ^{\circ}\text{C},  I_{S} = -4.0  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$ |   | -     | -                    | - 5.5            | V       |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>       | - T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 4.0 A, dl/dt = 100 A/μs <sup>b</sup>         |   | _     | 82                   | 160              | ns      |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>       |   |   | -     | 0.15                 | 0.30             | μC      |
| Forward Turn-On Time                          | t <sub>on</sub>       | Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> a            |   |       | y L <sub>S</sub> and | L <sub>D</sub> ) |         |

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

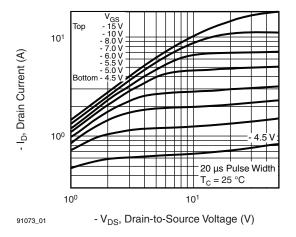


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

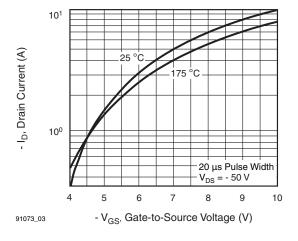


Fig. 3 - Typical Transfer Characteristics

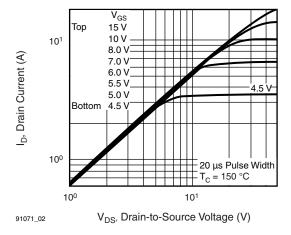


Fig. 2 - Typical Output Characteristics,  $T_C = 175$  °C

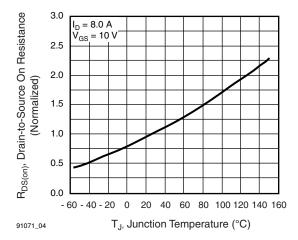


Fig. 4 - Normalized On-Resistance vs. Temperature

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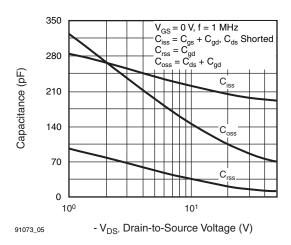


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

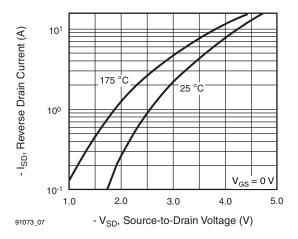


Fig. 7 - Typical Source-Drain Diode Forward Voltage

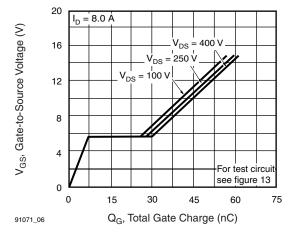


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

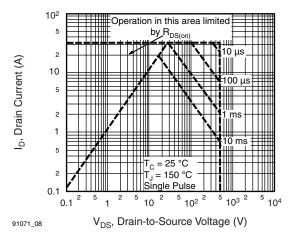


Fig. 8 - Maximum Safe Operating Area





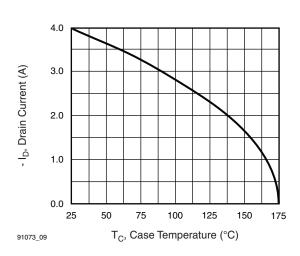


Fig. 9 - Maximum Drain Current vs. Case Temperature

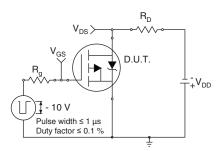


Fig. 10a - Switching Time Test Circuit

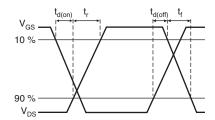


Fig. 10b - Switching Time Waveforms

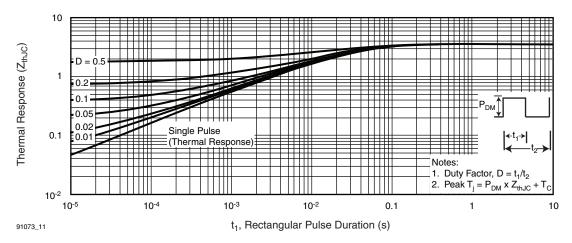


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

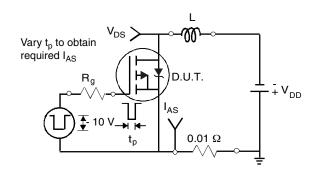


Fig. 12a - Unclamped Inductive Test Circuit

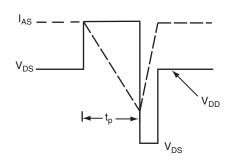


Fig. 12b - Unclamped Inductive Waveforms

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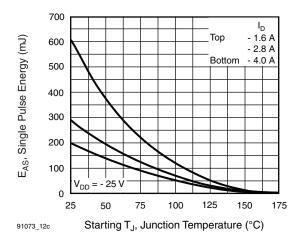


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

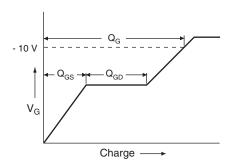


Fig. 13a - Basic Gate Charge Waveform

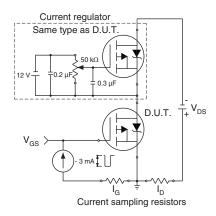
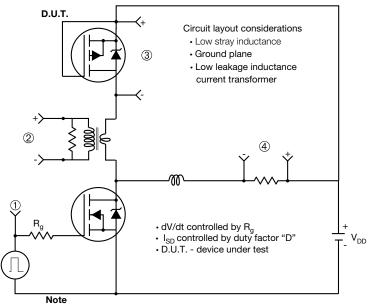


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

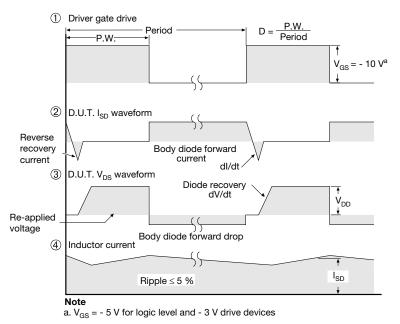


Fig. 14 - For P-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91073.





### **TO-263AB (HIGH VOLTAGE)**







|      | MILLIMETERS |      | INC   | HES   |
|------|-------------|------|-------|-------|
| DIM. | MIN.        | MAX. | MIN.  | MAX.  |
| Α    | 4.06        | 4.83 | 0.160 | 0.190 |
| A1   | 0.00        | 0.25 | 0.000 | 0.010 |
| b    | 0.51        | 0.99 | 0.020 | 0.039 |
| b1   | 0.51        | 0.89 | 0.020 | 0.035 |
| b2   | 1.14        | 1.78 | 0.045 | 0.070 |
| b3   | 1.14        | 1.73 | 0.045 | 0.068 |
| С    | 0.38        | 0.74 | 0.015 | 0.029 |
| c1   | 0.38        | 0.58 | 0.015 | 0.023 |
| c2   | 1.14        | 1.65 | 0.045 | 0.065 |
| D    | 8.38        | 9.65 | 0.330 | 0.380 |

|      | MILLIMETERS |       | INC       | HES   |
|------|-------------|-------|-----------|-------|
| DIM. | MIN.        | MAX.  | MIN.      | MAX.  |
| D1   | 6.86        | -     | 0.270     | -     |
| Е    | 9.65        | 10.67 | 0.380     | 0.420 |
| E1   | 6.22        | -     | 0.245     | ı     |
| е    | 2.54 BSC    |       | 0.100 BSC |       |
| Н    | 14.61       | 15.88 | 0.575     | 0.625 |
| L    | 1.78        | 2.79  | 0.070     | 0.110 |
| L1   | -           | 1.65  | ı         | 0.066 |
| L2   | -           | 1.78  | -         | 0.070 |
| L3   | 0.25 BSC    |       | 0.010     | BSC   |
| L4   | 4.78        | 5.28  | 0.188     | 0.208 |

ECN: S-82110-Rev. A, 15-Sep-08

DWG: 5970

#### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

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## RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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